

**Search Notes**

Application/Control No.

10/796,206

Examiner

Filip Zec

Applicant(s)/Patent under  
Reexamination

LEE, JU-YEON

Art Unit

3744

**SEARCHED**

Class	Subclass	Date	Examiner
62	3.1-3.7	6/10/2005	FZ
62	259.3	6/10/2005	FZ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/10/2005	FZ